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HUF75329D3S

Data Sheet

October 2013

N-Channel UltraFET Power MOSFET 55 V, 20 A, 26 mΩ

These N-Channel power MOSFETs are manufactured using the innovative UltraFET process. This advanced process technology achieves the lowest possible onresistance per silicon area, resulting in outstanding performance. This device is capable of withstanding high energy in the avalanche mode and the diode exhibits very low reverse recovery time and stored charge. It was designed for use in applications where power efficiency is important, such as switching regulators, switching converters, motor drivers, relay drivers, low-voltage bus switches, and power management in portable and batteryoperated products.

Formerly developmental type TA75329.

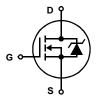
Ordering Information

PART NUMBER	PACKAGE	BRAND		
HUF75329D3ST	TO-252AA	75329D		

Features

- 20A, 55V
- Simulation Models
 - Temperature Compensated PSPICE® and SABER™ Models
 - SPICE and SABER Thermal Impedance Models Available on the WEB at: www.onsemi.com
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- Related Literature
 - TB334, "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol



Packaging

JEDEC TO-252AA



Absolute Maximum Ratings $T_C = 25^{\circ}C$, Unless Otherwise Specified

		UNITS
Drain to Source Voltage (Note 1) V _{DSS}	55	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)V _{DGR}	55	V
Gate to Source Voltage	±20	V
Drain Current		
Continuous (Figure 2)	20	A
Pulsed Drain Current	Figure 4	
Pulsed Avalanche Rating E _{AS}	Figure 6	
Power Dissipation	128	W
Derate Above 25 ^o C	0.86	W/ ^o C
Operating and Storage Temperature	-55 to 175	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10sT _L	300	°C
Package Body for 10s, See Techbrief 334	260	Oo

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $150^{\circ}C$.

Electrical Specifications	$T_{C} = 25^{\circ}C$, Unless Otherwise Specified					
PARAMETER		SYMBOL	TEST CONDITIONS			

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN	TYP	MAX	UNITS
OFF STATE SPECIFICATIONS							
Drain to Source Breakdown Voltage	BV _{DSS}	$I_D = 250 \mu A, V_{GS} =$	55	-	-	V	
Zero Gate Voltage Drain Current	IDSS	V_{DS} = 50V, V_{GS} =	0V	-	-	1	μΑ
		V_{DS} = 45V, V_{GS} =	0V, T _C = 150 ^o C	-	-	250	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V$	-	-	±100	nA	
ON STATE SPECIFICATIONS	I			I			
Gate to Source Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 25$	50μA (Figure 10)	2	-	4	V
Drain to Source On Resistance	rDS(ON)	I _D = 20A, V _{GS} = 10	-	0.022	0.026	Ω	
THERMAL SPECIFICATIONS							
Thermal Resistance Junction to Case	$R_{\theta JC}$	(Figure 3)	-	-	1.17	°C/W	
Thermal Resistance Junction to Ambient	R_{\thetaJA}	TO-252		-	-	100	°C/W
SWITCHING SPECIFICATIONS ($V_{GS} = 10^{10}$	/)			I			
Turn-On Time	tON	$V_{DD} = 30V, I_D \cong 20$	-	-	60	ns	
Turn-On Delay Time	t _{d(ON)}	$R_{L} = 1.5\Omega, V_{GS} = 10V,$ R _{GS} = 9.1Ω		-	7	-	ns
Rise Time	t _r			-	30	-	ns
Turn-Off Delay Time	td(OFF)			-	10	-	ns
Fall Time	t _f		-	33	-	ns	
Turn-Off Time	tOFF		-	-	65	ns	
GATE CHARGE SPECIFICATIONS				L			
Total Gate Charge	Q _{g(TOT)}	$V_{GS} = 0V$ to 20V	$V_{DD} = 30V,$	-	50	65	nC
Gate Charge at 10V	Q _{g(10)}	$V_{GS} = 0V$ to 10V	l _D ≅ 20A, R _I = 1.5Ω	-	32	40	nC
Threshold Gate Charge	Q _{g(TH)}	$V_{GS} = 0V$ to 2V	$I_{g(REF)} = 1.0mA$	-	2.0	2.5	nC
Gate to Source Gate Charge	Q _{gs}		(Figure 13)	-	5	-	nC
Reverse Transfer Capacitance	Q _{gd}			-	13	-	nC

Electrical Specifications $T_{C} = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS		
CAPACITANCE SPECIFICATIONS								
Input Capacitance	C _{ISS}	$V_{DS} = 25V, V_{GS} = 0V,$	-	1060	-	pF		
Output Capacitance	C _{OSS}	f = 1MHz (Figure 12)	-	405	-	pF		
Reverse Transfer Capacitance	C _{RSS}		-	95	-	pF		

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNITS
Source to Drain Diode Voltage	V _{SD}	I _{SD} = 20A	-	-	1.25	V
Reverse Recovery Time	t _{rr}	I_{SD} = 20A, dI _{SD} /dt = 100A/µs	-	-	68	ns
Reverse Recovered Charge	Q _{RR}	I_{SD} = 20A, dI_{SD}/dt = 100A/µs	-	-	120	nC

Typical Performance Curves

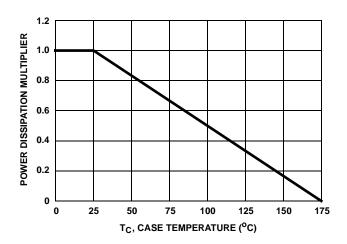


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

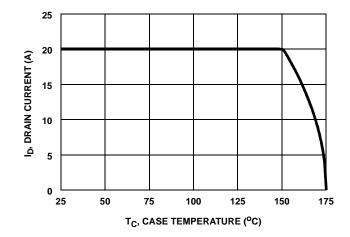
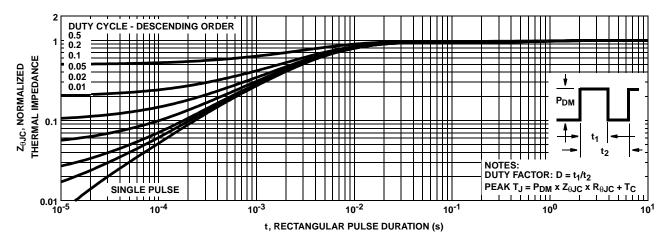
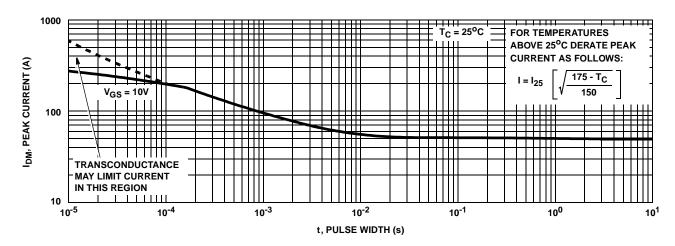


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE











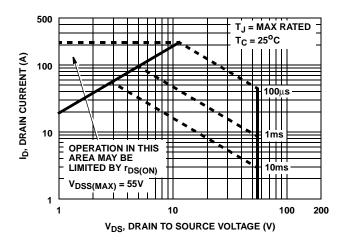
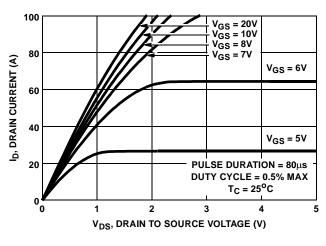
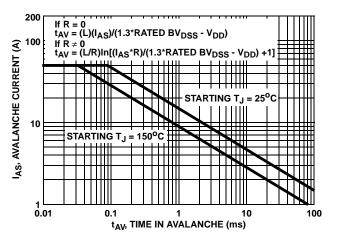
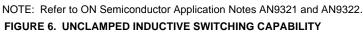


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA









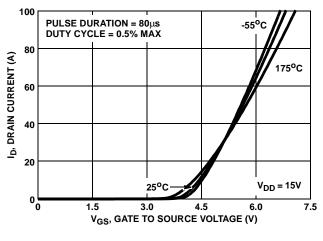


FIGURE 8. TRANSFER CHARACTERISTICS

Typical Performance Curves (Continued)

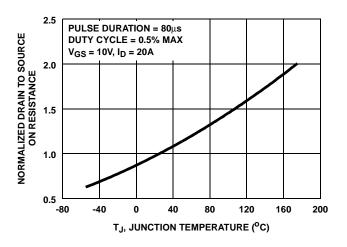


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

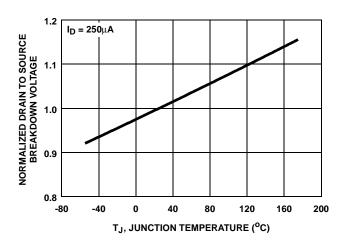
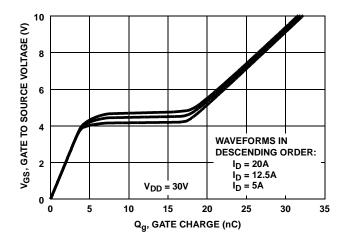


FIGURE 11. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE



NOTE: Refer to ON Semiconductor Application Notes AN7254 and AN7260. FIGURE 13. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT

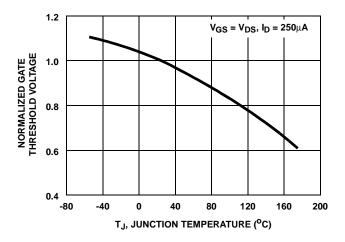


FIGURE 10. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

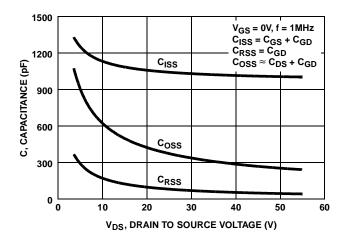


FIGURE 12. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

Test Circuits and Waveforms

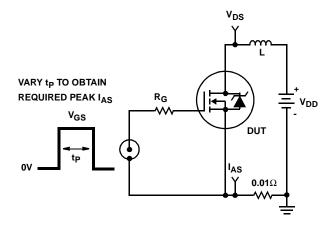


FIGURE 14. UNCLAMPED ENERGY TEST CIRCUIT

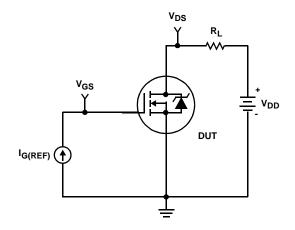


FIGURE 16. GATE CHARGE TEST CIRCUIT

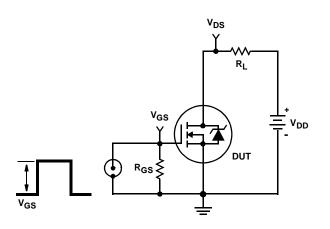


FIGURE 18. SWITCHING TIME TEST CIRCUIT

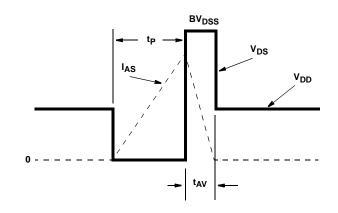


FIGURE 15. UNCLAMPED ENERGY WAVEFORMS

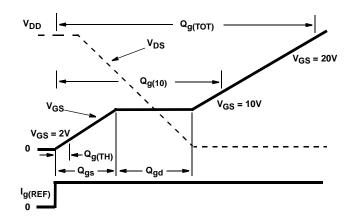
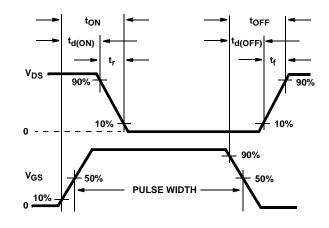
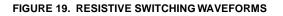


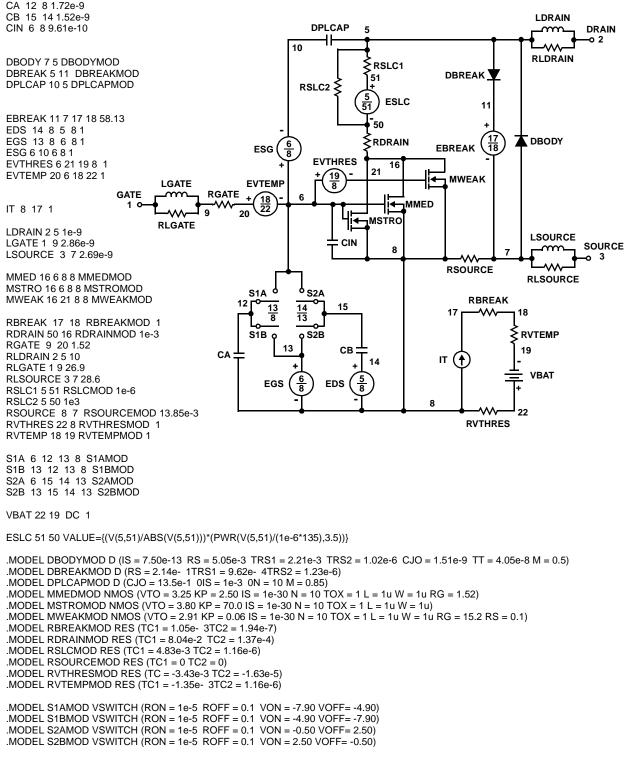
FIGURE 17. GATE CHARGE WAVEFORM





PSPICE Electrical Model

.SUBCKT HUF75329D 2 1 3 ; rev 6/19/97



.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

SABER Electrical Model

REV June 1997 template huf75329d n2, n1, n3 electrical n2, n1, n3 var i iscl d..model dbodymod = (is = 7.50e-13, cjo = 1.51e-9, tt = 4.05e-8, m = 0.5) d..model dbreakmod = () LDRAIN DPLCAP 5 DRAIN d..model dplcapmod = (cjo = 13.5e-10, is = 1e-30, n = 10, m = 0.85) m..model mmedmod = (type=_n, vto = 3.25, kp = 2.50, is = 1e-30, tox = 1) o 2 10 m..model mstrongmod = (type=_n, vto = 3.80, kp = 70, is = 1e-30, tox = 1) RLDRAIN m..model mweakmod = (type=_n, vto = 2.91, kp = 0.06, is = 1e-30, tox = 1) ≻RSLC1 RDBREAK sw_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -7.90, voff = -4.90) 51 RSLC2 sw_vcsp..model s1bmod = (ron = 1e-5, roff = 0.1, von = -4.90, voff = -7.90) 72 RDBODY sw_vcsp..model s2amod = (ron = 1e-5, roff = 0.1, von = -0.50, voff = 2.50) Ŧ ISCL sw_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 2.50, voff = -0.50) DBREAK 50 c.ca n12 n8 = 1.72e-9 71 RDRAIN <u>6</u> 8 c.cb n15 n14 = 1.52e-9 ESG 11 EVTHRES c.cin n6 n8 = 9.61e-10 16 21 <u>19</u> 8 MWEAK i∢ EVTEMP I GATE d.dbody n7 n71 = model=dbodymod DBODY RGATE GATE d.dbreak n72 n11 = model=dbreakmod 6 18 22 i∢ _MMED EBREAK d.dplcap n10 n5 = model=dplcapmod 1 0 9 20 \sim Чi∢ MSTRO RLGATE i.it n8 n17 = 1 18 LSOURCE CIN SOURCE 8 I.Idrain n2 n5 = 1e-9 3 • l.lgate n1 n9 = 2.86e-9 RSOURCE RLSOURCE l.lsource n3 n7 = 2.69e-9 k.k1 i(l.lgate) i(l.lsource) = l(l.lgate), l(l.lsource), 0.0085 S1A os2A RBREAK <u>14</u> 13 15 17 \sim 18 m.mmed n16 n6 n8 n8 = model=mmedmod, I = 1u, w = 1u m.mstrong n16 n6 n8 n8 = model=mstrongmod, I = 1u, w = 1u RVTEMP o S2B S1B m.mweak n16 n21 n8 n8 = model=mweakmod, I = 1u, w = 1u 13 CB 19 CA IT 14 res.rbreak n17 n18 = 1, tc1 = 1.05e-3, tc2 = 1.94e-7 res.rdbody n71 n5 = 5.05e-3, tc1 = 2.21e-3, tc2 = 1.02e-6VBAT <u>6</u> 8 EGS 5 EDS res.rdbreak n72 n5 = 2.14e-1, tc1 = 9.62e-4, tc2 = 1.23e-6 res.rdrain n50 n16 = 1e-3, tc1 = 8.04e-2, tc2 = 1.37e-4 8 res.rgate n9 n20 = 1.52 22 res.rldrain n2 n5 = 10 RVTHRES res.rlgate n1 n9 = 26.9 res.rlsource n3 n7 = 28.6 res.rslc1 n5 n51 = 1e-6, tc1 = 4.83e-3, tc2 = 1.16e-6 res.rslc2 n5 n50 = 1e3 res.rsource n8 n7 = 13.85e-3, tc1 = 0, tc2 = 0 res.rvtemp n18 n19 = 1, tc1 = -1.35e-3, tc2 = 1.16e-6 res.rvthres n22 n8 = 1, tc1 = -3.43e-3, tc2 = -1.63e-5 spe.ebreak n11 n7 n17 n18 = 58.13 spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esg n6 n10 n6 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 spe.evthres n6 n21 n19 n8 = 1 sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc = 1 equations { i(n51->n50) + = iscliscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/135))**3.5)))

SPICE Thermal Model

REV 23 February 1999

HUF75329D

CTHERM1 th 6 2.80e-3 CTHERM2 6 5 1.00e-2 CTHERM3 5 4 6.80e-3 CTHERM4 4 3 7.00e-3 CTHERM5 3 2 1.60e-2 CTHERM6 2 tl 15.55

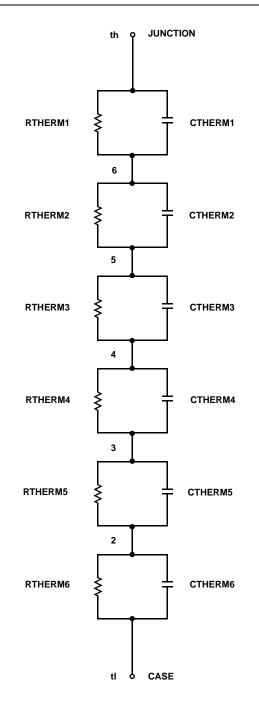
RTHERM1 th 6 7.94e-3 RTHERM2 6 5 1.98e-2 RTHERM3 5 4 5.57e-2 RTHERM4 4 3 3.13e-1 RTHERM5 3 2 4.71e-1 RTHERM6 2 tl 6.26e-2

SABER Thermal Model

SABER thermal model HUF75329D

template thermal_model th tl thermal_c th, tl { ctherm.ctherm1 th 6 = 2.80e-3ctherm.ctherm2 6 5 = 1.00e-2ctherm.ctherm3 5 4 = 6.80e-3ctherm.ctherm4 4 3 = 7.00e-3ctherm.ctherm5 3 2 = 1.60e-2ctherm.ctherm6 2 tl = 15.55

rtherm.rtherm1 th 6 = 7.94e-3 rtherm.rtherm2 6 5 = 1.98e-2 rtherm.rtherm3 5 4 = 5.57e-2 rtherm.rtherm4 4 3 = 3.13e-1 rtherm.rtherm5 3 2 = 4.71e-1 rtherm.rtherm6 2 tl = 6.26e-2 }



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